## **Description**

The Si2343DS-T1-E3 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.



#### **General Features**

 $V_{DS}$  = -30V, $I_D$  = -4.1A  $R_{DS(ON)}$  <56m $\Omega$  @  $V_{GS}$ =10V

## **Application**

High power and current handing capability
Lead free product is acquired
Surface mount package
PWM applications
Load switch
Power management

P-Channel MOSFET

# **Package Marking and Ordering Information**

| Product ID     | Pack   | Brand      | Qty(PCS) |
|----------------|--------|------------|----------|
| Si2343DS-T1-E3 | SOT-23 | HXY MOSFET | 3000     |

# Absolute Maximum Ratings (T<sub>A</sub>=25 ℃ unless otherwise noted)

| Symbol                           | Parameter  | Limit      | Unit       |
|----------------------------------|--|------------|------------|
| V <sub>DS</sub>                  | Drain-Source Voltage                             | -30        | V          |
| V <sub>G</sub> s                 | Gate-Source Voltage                              | ±20        | V          |
| ID                               | Drain Current-Continuous                         | -4.1       | А          |
| Ідм                              | Drain Current-Pulsed (Note 1)                    | -13        | А          |
| P <sub>D</sub>                   | Maximum Power Dissipation                        | 1.32       | W          |
| T <sub>J</sub> ,T <sub>STG</sub> | Operating Junction and Storage Temperature Range | -55 To 150 | $^{\circ}$ |
| Reja                             | Thermal Resistance, Junction-to-Ambient (Note 2) | 125        | °C/W       |



## Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

| Symbol                              | Parameter                                      | Conditions   | Min. | Тур.  | Max. | Unit  |  |
|-------------------------------------|--|--|------|-------|------|-------|--|
| BV <sub>DSS</sub>                   | Drain-Source Breakdown Voltage                 | $V_{GS}$ =0 $V$ , $I_D$ =-250 $u$ A                                  | -30  |       |      | V     |  |
| △BV <sub>DSS</sub> /△T <sub>J</sub> | BVDSS Temperature Coefficient                  | Reference to 25°C , I <sub>D</sub> =-1mA                             |      | -0.02 |      | V/°C  |  |
| R <sub>DS(ON)</sub>                 | Otatia Dania Ocuma On Banistana 2              | $V_{GS}$ =-10 $V$ , $I_D$ =-3 $A$                                    |      | 48    | 56   | mΩ    |  |
|                                     | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-1.5A                       |      | 78    | 90   |       |  |
| V <sub>GS(th)</sub>                 | Gate Threshold Voltage                         | \/aa=\/aa  a = 250uA   | -1.2 | -1.5  | -2.5 | ٧     |  |
| $\triangle V_{GS(th)}$              | V <sub>GS(th)</sub> Temperature Coefficient    | $V_{GS}=V_{DS}$ , $I_D$ =-250uA                                      |      | 4.32  |      | mV/°C |  |
| ı                                   | Drain-Source Leakage Current                   | V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C   |      |       | -1   | uA    |  |
| I <sub>DSS</sub>                    |  | V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C   |      |       | -5   |       |  |
| I <sub>GSS</sub>                    | Gate-Source Leakage Current                    | $V_{GS}=\pm20V$ , $V_{DS}=0V$  |      |       | ±100 | nA    |  |
| gfs                                 | Forward Transconductance                       | V <sub>DS</sub> =-5V , I <sub>D</sub> =-3A                           |      | 4.8   |      | S     |  |
| Rg                                  | Gate Resistance                                | V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz                   |      | 24    | 48   | Ω     |  |
| Qg                                  | Total Gate Charge (-4.5V)                      |  |      | 5.22  | 7.3  | nC    |  |
| Q <sub>gs</sub>                     | Gate-Source Charge                             | V <sub>DS</sub> =-20V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3A |      | 1.25  | 1.8  |       |  |
| Q <sub>gd</sub>                     | Gate-Drain Charge                              |  |      | 2.3   | 3.2  |       |  |
| T <sub>d(on)</sub>                  | Turn-On Delay Time                             |  |      | 18.4  | 37   |       |  |
| Tr                                  | Rise Time                                      | $V_{DD}$ =-15V , $V_{GS}$ =-10V , $R_{G}$ =3.3 $\Omega$              |      | 11.4  | 21   | ns    |  |
| $T_{d(off)}$                        | Turn-Off Delay Time                            | I <sub>D</sub> =-1A  |      | 39.4  | 79   |       |  |
| T <sub>f</sub>                      | Fall Time                                      |  |      | 5.2   | 10.4 |       |  |
| Ciss                                | Input Capacitance                              |  |      | 463   | 650  |       |  |
| Coss                                | Output Capacitance                             | V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz                 |      | 82    | 115  | pF    |  |
| Crss                                | Reverse Transfer Capacitance                   |  |      | 68    | 95   |       |  |
| ls                                  | Continuous Source Current <sup>1,4</sup>       | V <sub>G</sub> =V <sub>D</sub> =0V , Force Current                   |      |       | -3.2 | Α     |  |
| I <sub>SM</sub>                     | Pulsed Source Current <sup>2,4</sup>           | VG-VD-UV, FOICE Current  | -    |       | -13  | Α     |  |
| V <sub>SD</sub>                     | Diode Forward Voltage <sup>2</sup>             | V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C     |      |       | -1   | V     |  |

### Note:

<sup>1.</sup> The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

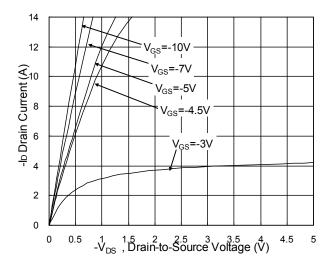
<sup>2.</sup>The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

<sup>3.</sup>The power dissipation is limited by 150°C junction temperature

<sup>4.</sup> The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



## **Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

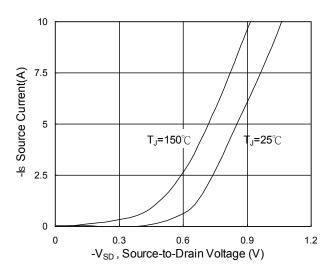


Fig.3 Source Drain Forward Characteristics

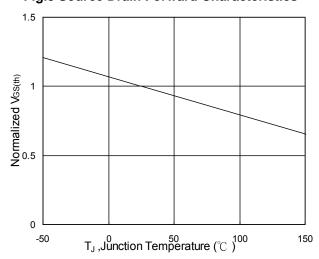


Fig.5 Normalized V<sub>GS(th)</sub> vs. T<sub>J</sub>

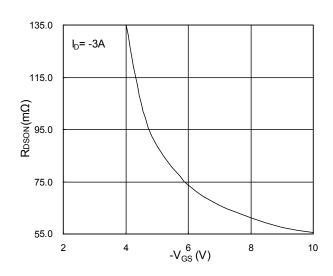


Fig.2 On-Resistance vs. G-S Voltage

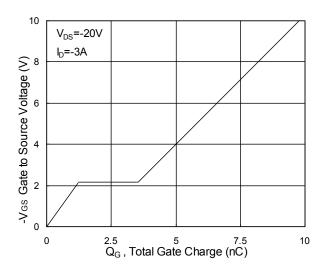


Fig.4 Gate-Charge Characteristics

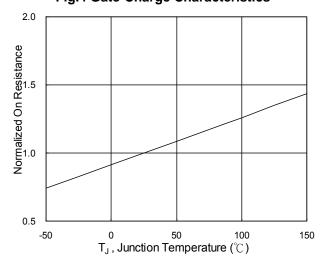
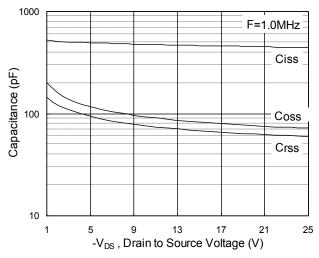


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



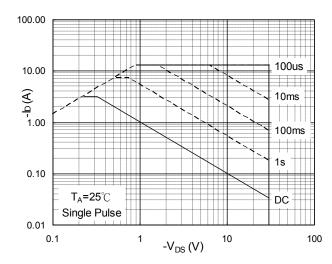


Fig.7 Capacitance

Fig.8 Safe Operating Area

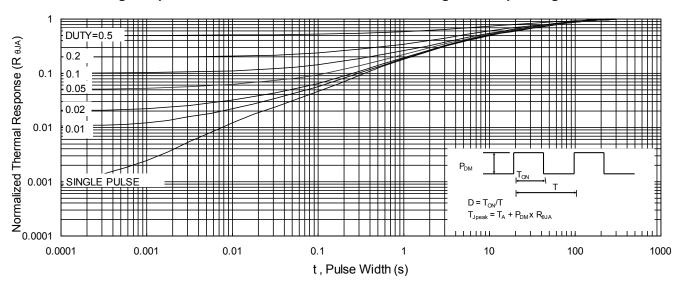
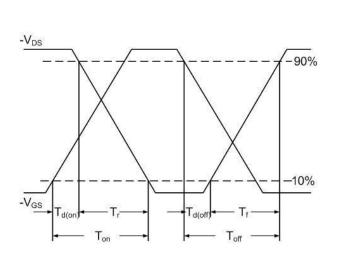


Fig.9 Normalized Maximum Transient Thermal Impedance



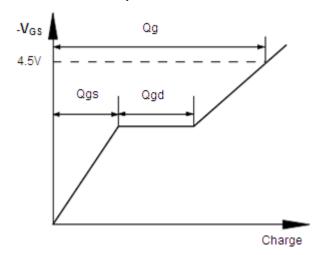
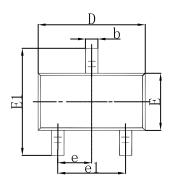


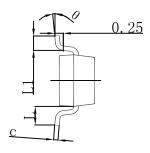
Fig.10 Switching Time Waveform

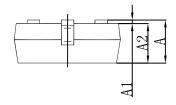
Fig.11 Gate Charge Waveform



# **SOT-23 Package Outline Dimensions**

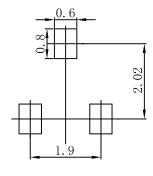






| Symbol | Dimensions In Millimeters |       | Dimensions In Inches |       |  |
|--------|---------------------------|-------|----------------------|-------|--|
|        | Min                       | Max   | Min                  | Max   |  |
| Α      | 0.900                     | 1.150 | 0.035                | 0.045 |  |
| A1     | 0.000                     | 0.100 | 0.000                | 0.004 |  |
| A2     | 0.900                     | 1.050 | 0.035                | 0.041 |  |
| b      | 0.300                     | 0.500 | 0.012                | 0.020 |  |
| С      | 0.080                     | 0.150 | 0.003                | 0.006 |  |
| D      | 2.800                     | 3.000 | 0.110                | 0.118 |  |
| E      | 1.200                     | 1.400 | 0.047                | 0.055 |  |
| E1     | 2.250                     | 2.550 | 0.089                | 0.100 |  |
| е      | 0.950 TYP                 |       | 0.037 TYP            |       |  |
| e1     | 1.800                     | 2.000 | 0.071                | 0.079 |  |
| L      | 0.550 REF                 |       | 0.022 REF            |       |  |
| L1     | 0.300                     | 0.500 | 0.012                | 0.020 |  |
| θ      | 0°                        | 8°    | 0°                   | 8°    |  |

# **SOT-23 Suggested Pad Layout**



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
  3.The pad layout is for reference purposes only.



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